
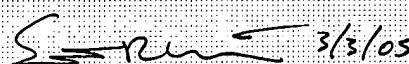



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/686,794	HSIEH, CHIA-TA	
	Examiner	Art Unit	
	Scott R. Wilson	2826	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
257	314			257	288	300	239	261	
INTERNATIONAL CLASSIFICATION				438	201	211	257		
H01L	29176			711	603				
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 (Assistant Examiner) (Date) 3/3/05	 NATHAN J. FLYNN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) (Date)	Total Claims Allowed: 16 O.G. Print Claim(s) 1 O.G. Print Fig. 44
(Legal Instruments Examiner) (Date)		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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